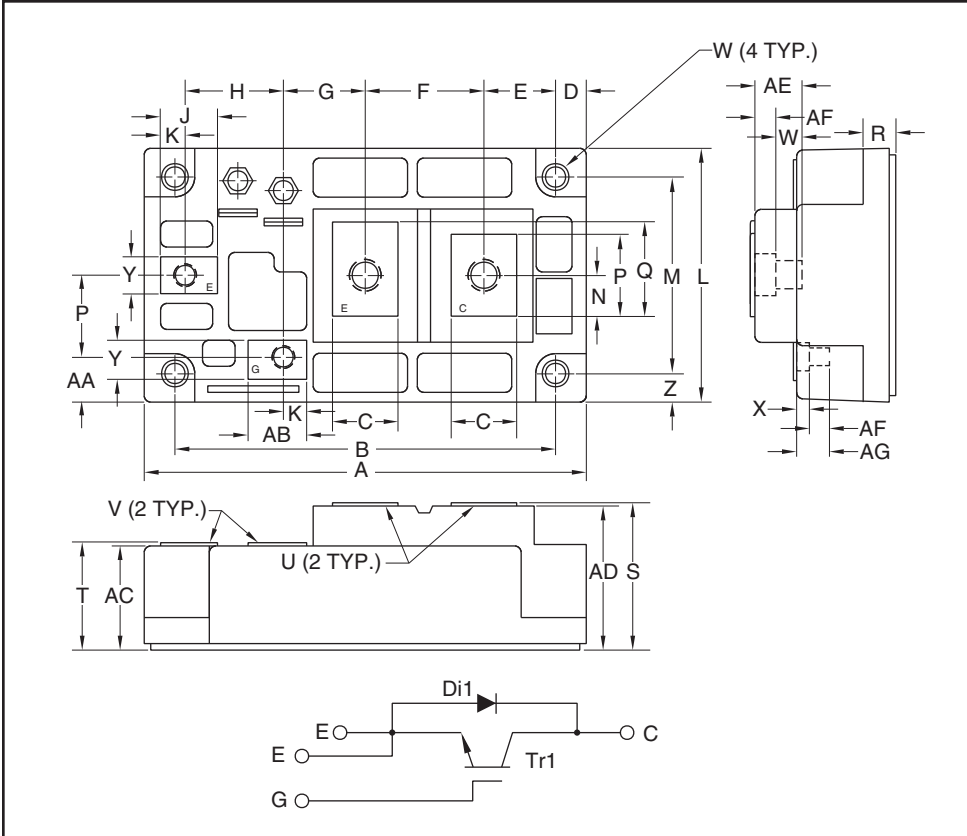


### Single IGBT A-Series Module 500 Amperes/1700 Volts



#### Description:

Powerex IGBT Modules are designed for use in switching applications. Each module consists of one IGBT Transistor in a single configuration with a reverse connected super-fast recovery free-wheel diode. All components and interconnects are isolated from the heat sinking baseplate, offering simplified system assembly and thermal management.

#### Features:

- Low Drive Power
- Low  $V_{CE(sat)}$
- Discrete Super-Fast Recovery Free-Wheel Diode
- Isolated Baseplate for Easy Heat Sinking

#### Applications:

- DC Chopper
- Inverter
- UPS
- Forklift

#### Ordering Information:

Example: Select the complete part module number you desire from the table below -i.e. CM500HA-34A is a 1700V ( $V_{CES}$ ), 500 Ampere Single IGBT Power Module.

Outline Drawing and Circuit Diagram

Dimensions	Inches	Millimeters
A	4.25	108.0
B	3.66±0.01	93.0±0.25
C	0.63	16.0
D	0.30	7.5
E	0.69	17.5
F	1.14	29.0
G	0.79	20.0
H	0.94	24.0
J	0.55	13.9
K	0.24	6.0
L	2.44	62.0
M	1.89±0.01	48.0±0.25
N	0.39	10.0
P	0.79	20.0
Q	0.9	23.0
R	0.33	8.5

Dimensions	Inches	Millimeters
S	1.42+0.04/-0.02	36.0+1.0/-0.5
T	1.02+0.04/-0.02	25.8+1.0/-0.5
U	M6 Metric	M6
V	M4 Metric	M4
W	0.256	6.5
X	0.126	3.2
Y	0.35	9.0
Z	0.27	7.0
AA	0.43	11.0
AB	0.53	13.55
AC	0.98	25.0
AD	1.37	35.0
AE	0.45	11.5
AF	0.19	5.0
AG	0.32	8.2

Type	Current Rating Amperes	$V_{CES}$ Volts (x 50)
CM	500	34

**CM500HA-34A**  
**Single IGBT A-Series Module**  
 500 Amperes/1700 Volts

## Absolute Maximum Ratings, $T_j = 25^\circ\text{C}$ unless otherwise specified

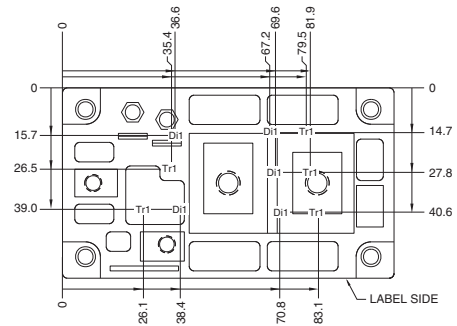
Characteristics	Symbol	Rating	Units
Collector-Emitter Voltage (G-E Short-Circuited)	$V_{CES}$	1700	Volts
Gate-Emitter Voltage (C-E Short-Circuited)	$V_{GES}$	$\pm 20$	Volts
Collector Current (DC, $T_C = 87^\circ\text{C}$ ) <sup>*2</sup>	$I_C$	500	Amperes
Collector Current (Pulse, Repetitive) <sup>*3</sup>	$I_{CRM}$	1000	Amperes
Total Power Dissipation ( $T_C = 25^\circ\text{C}$ ) <sup>*2,*4</sup>	$P_{tot}$	5000	Watts
Emitter Current, Freewheeling Diode Forward Current ( $T_C = 25^\circ\text{C}$ ) <sup>*2,*4</sup>	$I_E^{*1}$	500	Amperes
Emitter Current, Freewheeling Diode Forward Current (Pulse, Repetitive) <sup>*3</sup>	$I_{ERM}^{*1}$	1000	Amperes
Junction Temperature	$T_j$	-40 ~ +150	$^\circ\text{C}$
Storage Temperature	$T_{stg}$	-40 ~ +125	$^\circ\text{C}$
Isolation Voltage (Terminals to Baseplate, RMS, $f = 60\text{Hz}$ , AC 1 minute)	$V_{iso}$	3500	Volts

\*1 Represent ratings and characteristics of the anti-parallel, emitter-to-collector free wheeling diode (FWDi).

\*2 Case temperature ( $T_C$ ) and heatsink temperature ( $T_S$ ) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips. Refer to the figure to the right for chip location.

\*3 Pulse width and repetition rate should be such that device junction temperature ( $T_j$ ) does not exceed  $T_{j(max)}$  rating.

\*4 Junction temperature ( $T_j$ ) should not increase beyond maximum junction temperature ( $T_{j(max)}$ ) rating.



Tr1: IGBT, D1i: FWDi  
 EACH MARK POINTS TO THE CENTER POSITION OF EACH CHIP

**CM500HA-34A**  
**Single IGBT A-Series Module**  
 500 Amperes/1700 Volts

**Electrical Characteristics,  $T_j = 25^\circ\text{C}$  unless otherwise specified**

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Collector-Emitter Cutoff Current	$I_{CES}$	$V_{CE} = V_{CES}$ , G-E Short-Circuited	—	—	1.0	mA
Gate-Emitter Leakage Current	$I_{GES}$	$\pm V_{GE} = V_{GES}$ , C-E Short-Circuited	—	—	3.0	$\mu\text{A}$
Gate-Emitter Threshold Voltage	$V_{GE(th)}$	$I_C = 50\text{mA}$ , $V_{CE} = 10\text{V}$	5.5	7.0	8.5	Volts
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 500\text{A}$ , $V_{GE} = 15\text{V}$ , $T_j = 25^\circ\text{C}^{*6}$	—	2.2	3.0	Volts
		$I_C = 500\text{A}$ , $V_{GE} = 15\text{V}$ , $T_j = 125^\circ\text{C}^{*6}$	—	2.45	—	Volts
Input Capacitance	$C_{ies}$		—	—	120	nF
Output Capacitance	$C_{oes}$	$V_{CE} = 10\text{V}$ , G-E Short-Circuited	—	—	14.0	nF
Reverse Transfer Capacitance	$C_{res}$		—	—	2.6	nF
Gate Charge	$Q_G$	$V_{CC} = 1000\text{V}$ , $I_C = 500\text{A}$ , $V_{GE} = 15\text{V}$	—	3300	—	nC
Turn-on Delay Time	$t_{d(on)}$		—	—	900	ns
Rise Time	$t_r$	$V_{CC} = 1000\text{V}$ , $I_C = 500\text{A}$ , $V_{GE} = \pm 15\text{V}$ ,	—	—	500	ns
Turn-off Delay Time	$t_{d(off)}$	$R_G = 3.0\Omega$ , Inductive Load	—	—	700	ns
Fall Time	$t_f$		—	—	350	ns
Emitter-Collector Voltage	$V_{EC}^{*1}$	$I_E = 500\text{A}$ , G-E Short-Circuited <sup>*6</sup>	—	2.3	3.2	Volts
Reverse Recovery Time	$t_{rr}^{*1}$	$V_{CC} = 1000\text{V}$ , $I_E = 500\text{A}$ , $V_{GE} = \pm 15\text{V}$	—	—	650	ns
Reverse Recovery Charge	$Q_{rr}^{*1}$	$R_G = 3.0\Omega$ , Inductive Load	—	50	—	$\mu\text{C}$
Turn-on Switching Energy per Pulse	$E_{on}$	$V_{CC} = 1000\text{V}$ , $I_C = I_E = 500\text{A}$ ,	—	267.8	—	mJ
Turn-off Switching Energy per Pulse	$E_{off}$	$V_{GE} = \pm 15\text{V}$ , $R_G = 3.0\Omega$ ,	—	138.5	—	mJ
Reverse Recovery Energy per Pulse	$E_{rr}^{*1}$	$T_j = 125^\circ\text{C}$ , Inductive Load	—	98.1	—	mJ
Internal Gate Resistance	$r_g$	$T_C = 25^\circ\text{C}$	—	1.0	—	$\Omega$
External Gate Resistance	$R_G$	—	3.0	—	10	$\Omega$

\*1 Represent ratings and characteristics of the anti-parallel, emitter-to-collector free wheeling diode (FWDI).

\*6 Pulse width and repetition rate should be such as to cause negligible temperature rise.

**CM500HA-34A**  
**Single IGBT A-Series Module**  
 500 Amperes/1700 Volts

**Thermal Resistance Characteristics,  $T_j = 25^\circ\text{C}$  unless otherwise specified**

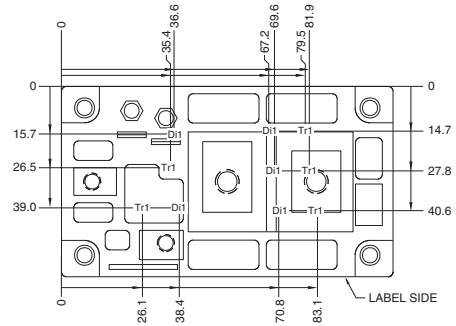
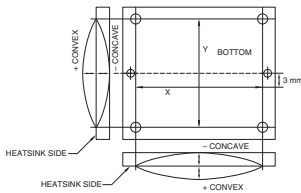
Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal Resistance, Junction to Case <sup>*2</sup>	$R_{th(j-c)Q}$	IGBT Part	—	—	25	K/kW
Thermal Resistance, Junction to Case <sup>*2</sup>	$R_{th(j-c)D}$	FWDi Part	—	—	42	K/kW
Contact Thermal Resistance, Case to Heatsink	$R_{th(c-s)}$	Thermal Grease Applied <sup>*7</sup>	—	20	—	K/kW

**Mechanical Characteristics**

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Mounting Torque	$M_t$	Main Terminals, M6 Screw	18	22	26	in-lb
		Auxiliary Terminals, M4 Screw	9	11	13	in-lb
		Mounting to Heatsink, M6 Screw	18	22	26	in-lb
Weight	m		—	480	—	Grams
Flatness of Baseplate	$e_c$	On Centerline X, Y <sup>*5</sup>	$\pm 0$	—	+100	$\mu\text{m}$

<sup>\*2</sup> Case temperature ( $T_C$ ) and heatsink temperature ( $T_S$ ) is measured on the surface (mounting side) of the baseplate and the heatsink side just under the chips. Refer to the figure to the right for chip location.

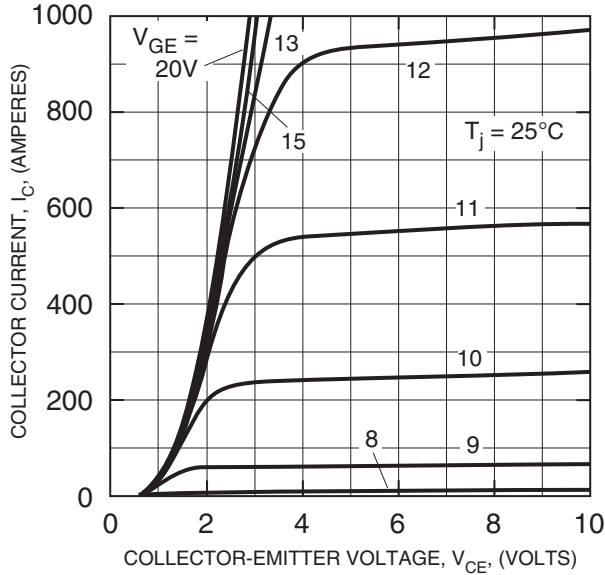
The heatsink thermal resistance should be measured just under the chips.  
<sup>\*5</sup> Baseplate (mounting side) flatness measurement points (X, Y) are shown in the figure below.  
<sup>\*7</sup> Typical value is measured by using thermally conductive grease of  $\lambda = 0.9 \text{ [W/(m} \cdot \text{K)]}$ .



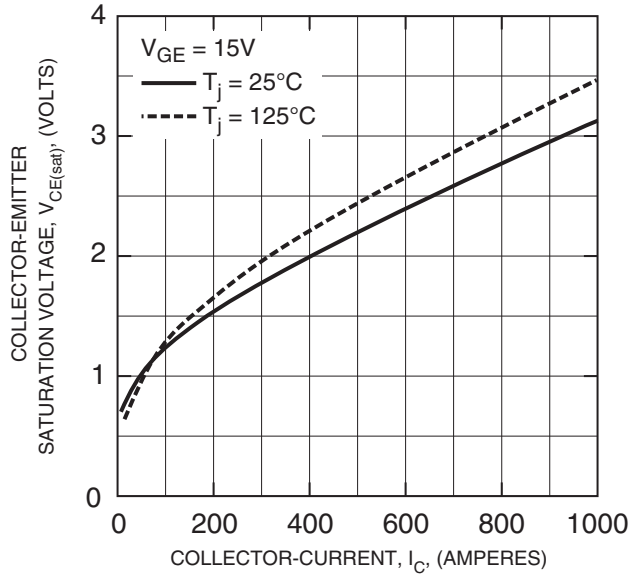
Tr1: IGBT, D11: FWDi  
 EACH MARK POINTS TO THE CENTER POSITION OF EACH CHIP

**CM500HA-34A**  
**Single IGBT A-Series Module**  
 500 Amperes/1700 Volts

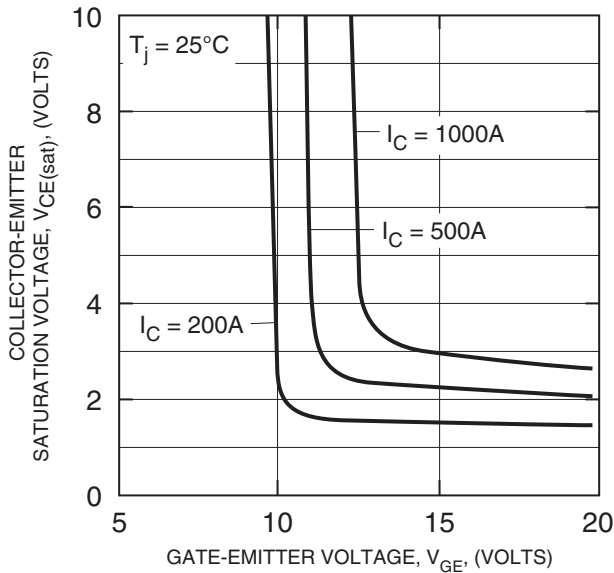
**OUTPUT CHARACTERISTICS (TYPICAL)**



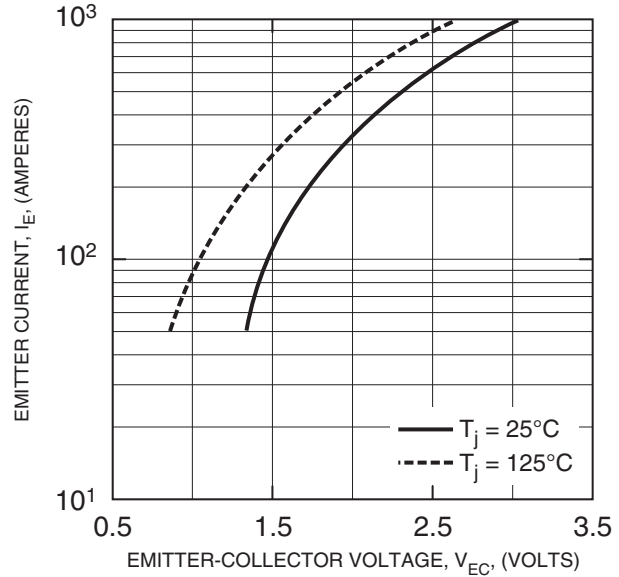
**COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)**



**COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)**

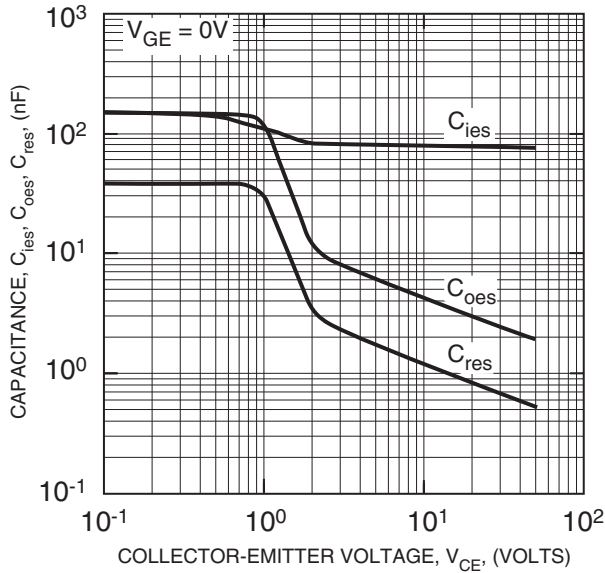


**FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)**

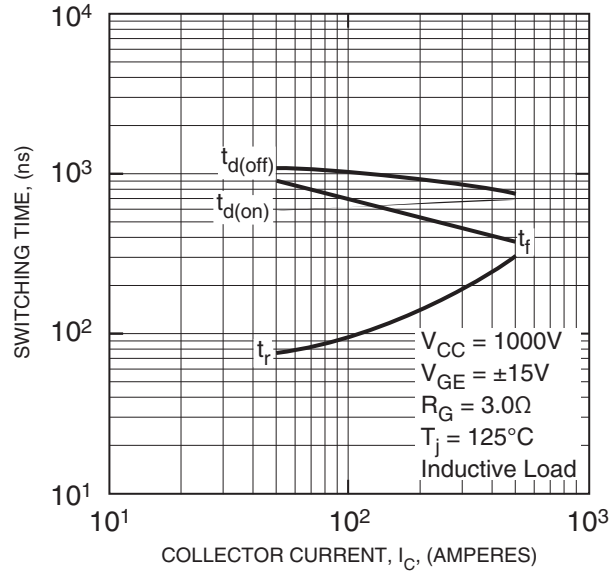


**CM500HA-34A**  
**Single IGBT A-Series Module**  
 500 Amperes/1700 Volts

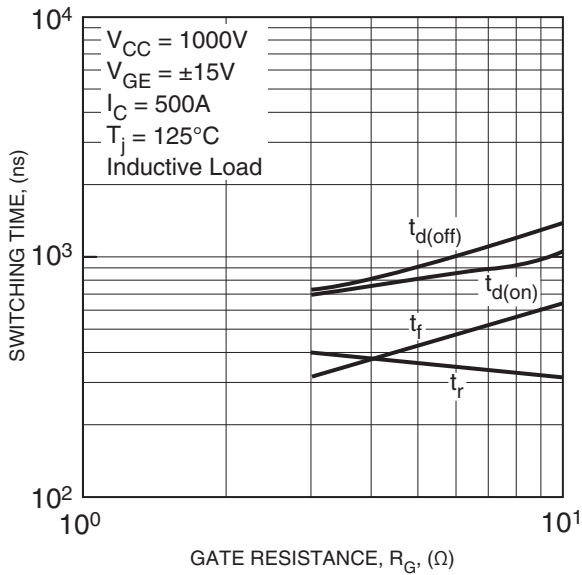
**CAPACITANCE VS.  $V_{CE}$**   
**(TYPICAL)**



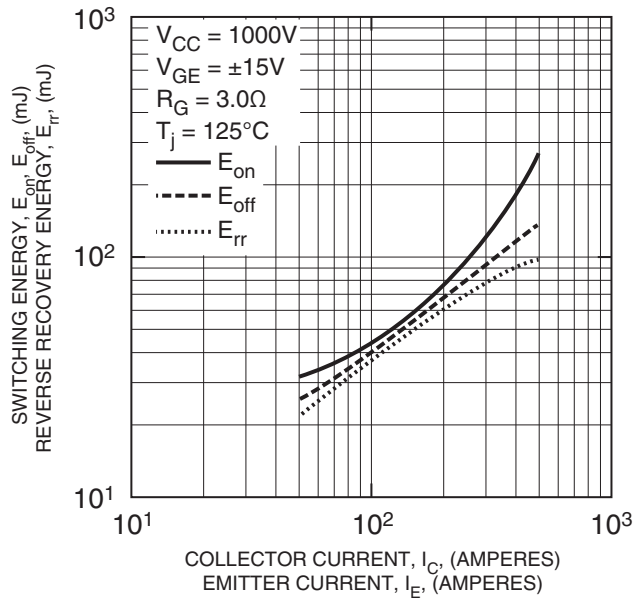
**HALF-BRIDGE SWITCHING CHARACTERISTICS**  
**(TYPICAL)**



**SWITCHING TIME VS. GATE RESISTANCE**  
**(TYPICAL)**

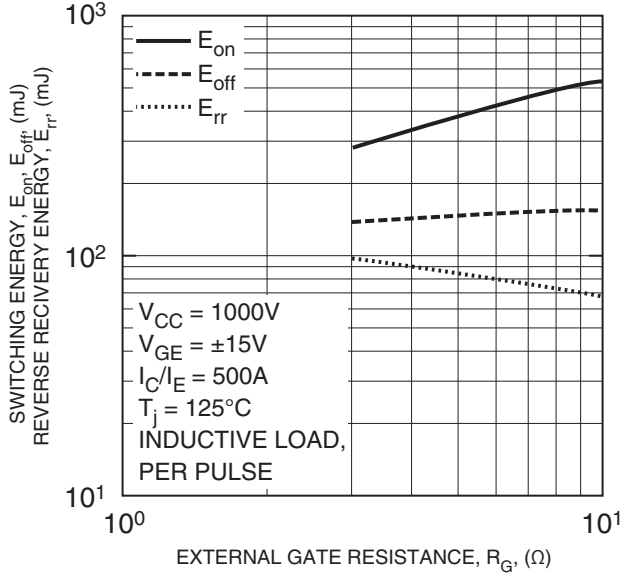


**HALF-BRIDGE SWITCHING CHARACTERISTICS**  
**(TYPICAL)**

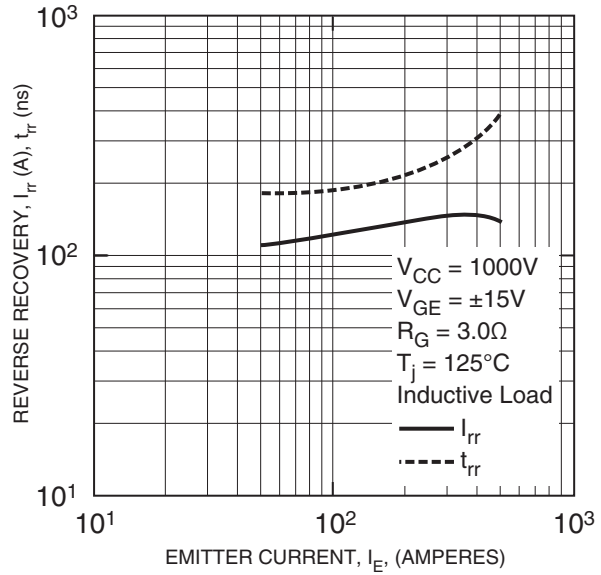


**CM500HA-34A**  
**Single IGBT A-Series Module**  
 500 Amperes/1700 Volts

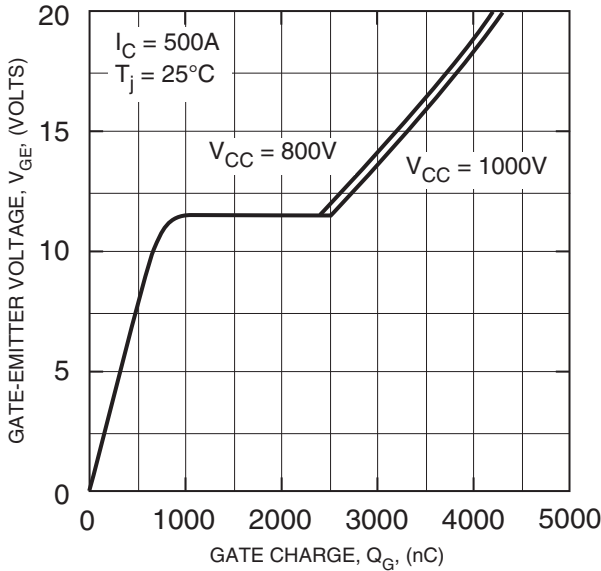
**HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)**



**REVERSE RECOVERY CHARACTERISTICS (TYPICAL)**



**GATE CHARGE VS.  $V_{GE}$**



**TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)**

